

***abTEM***



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# ***abTEM: transmission electron microscopy from first principles***

*Hyperspy 2025*  
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Usage poll:

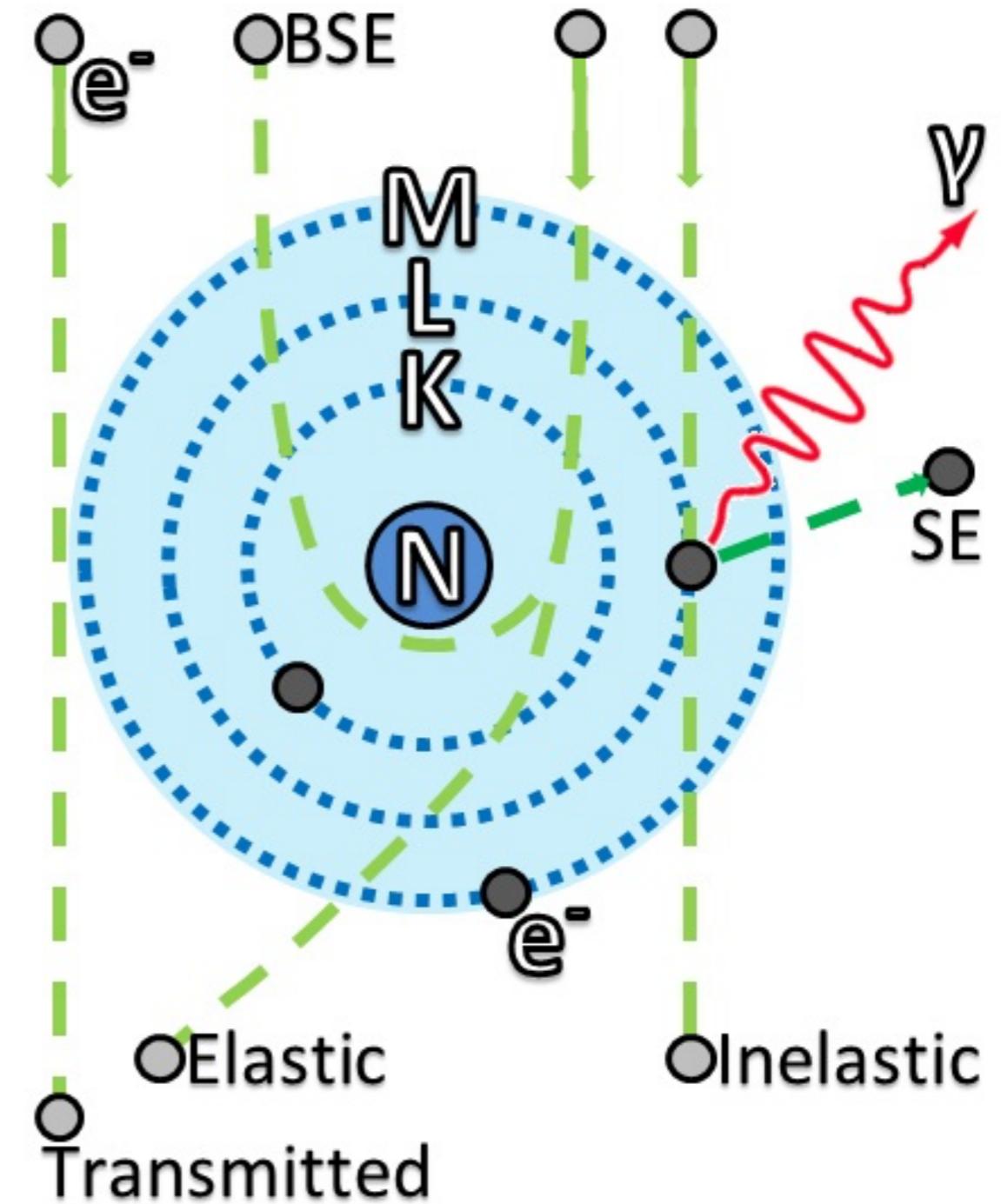


# Electron scattering



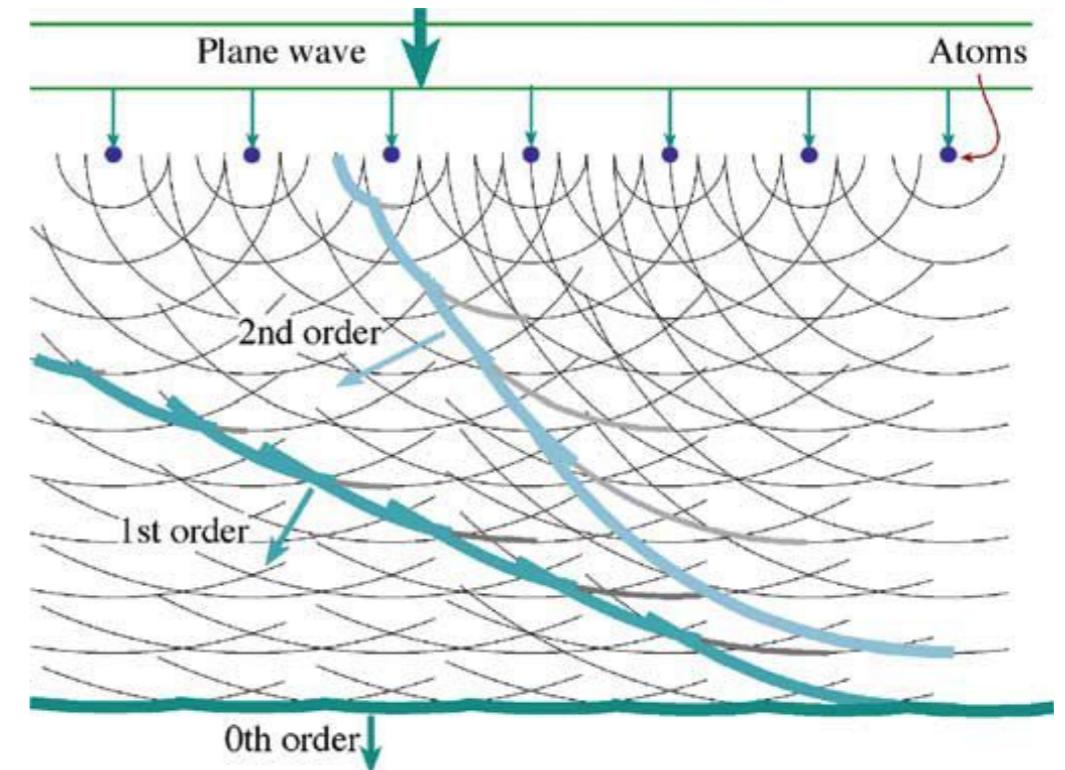
For TEM diffraction and image contrast, we (mostly) only need to consider **low-angle elastic scattering**, which is **coherent**

- Beam Electron
- Atomic Shell Electron
- Electron Cloud
- Beam Electron Path
- Secondary Electron Path
- Characteristic X-Ray



## Quantum mechanical description

- Angular distribution of scattered intensity
  - For atoms, *atomic form factor*,  $f$
  - For crystals, *structure factor*,  $F$ 
    - Preferred directions due to constructive interference
- Full analytical description in general not feasible
  - Quantum mechanical many-body problem
  - Approximate analytical solution can be obtained as a *Fourier transform of the potential*
  - In general: numerical simulation of scattering



# Scattering simulations



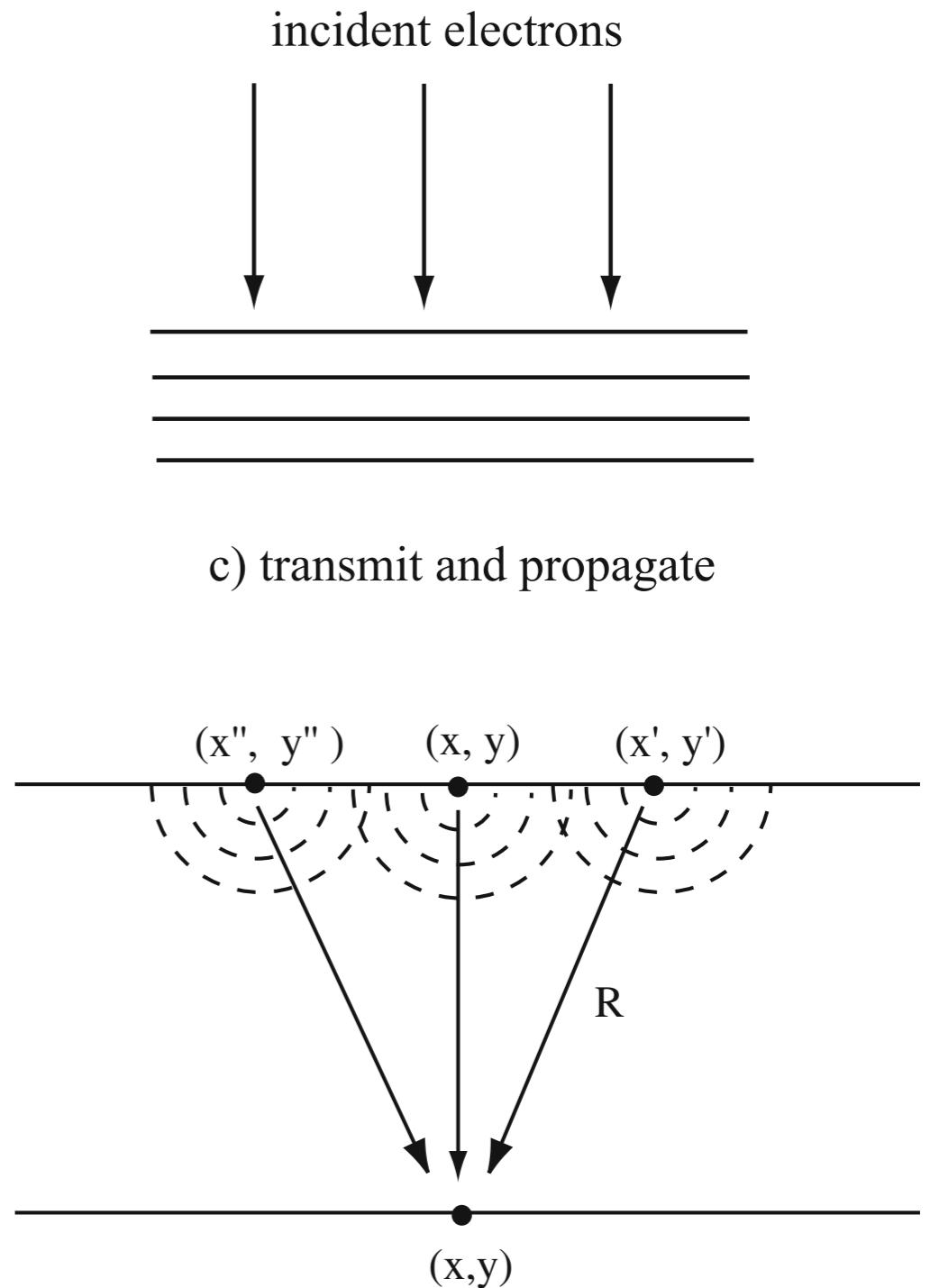
- Schrödinger equation for electron wave transmitting through specimen
  - Including time evolution explicitly would be prohibitively expensive
    - Very small wavelength/high frequency = very small sampling
  - We can use time-independent Schrödinger equation instead
- Some approximation are still needed
  - “Fast electrons” = initial kinetic energy  $\gg$  energy change in specimen
    - Motion predominantly in the z direction with small perturbation
  - Non-relativistic equations
    - However, with correct relativistic mass and wavelength
    - Fine at  $\sim$ 100 keV, less so at 1 MeV (latter nowadays quite rare)
- Numerical implementation: fast Fourier transforms!

# Numerical implementations



## Scattering simulations

- Multiple formalisms available
  - FFT
  - Bloch-wave (*added to abTEM!*)
  - real-space (*standard in abTEM*)
  - PRISM (*fastest in abTEM* :)
- Most commonly: real-space simulations based on **multislice algorithm**
  - Sample potential divided into thin slices
  - Project, transmit, propagate...
    - Modify *transmission* step to include magnetic vector potential



# Weak phase object



Wavefunction for plane wave moving along z axis

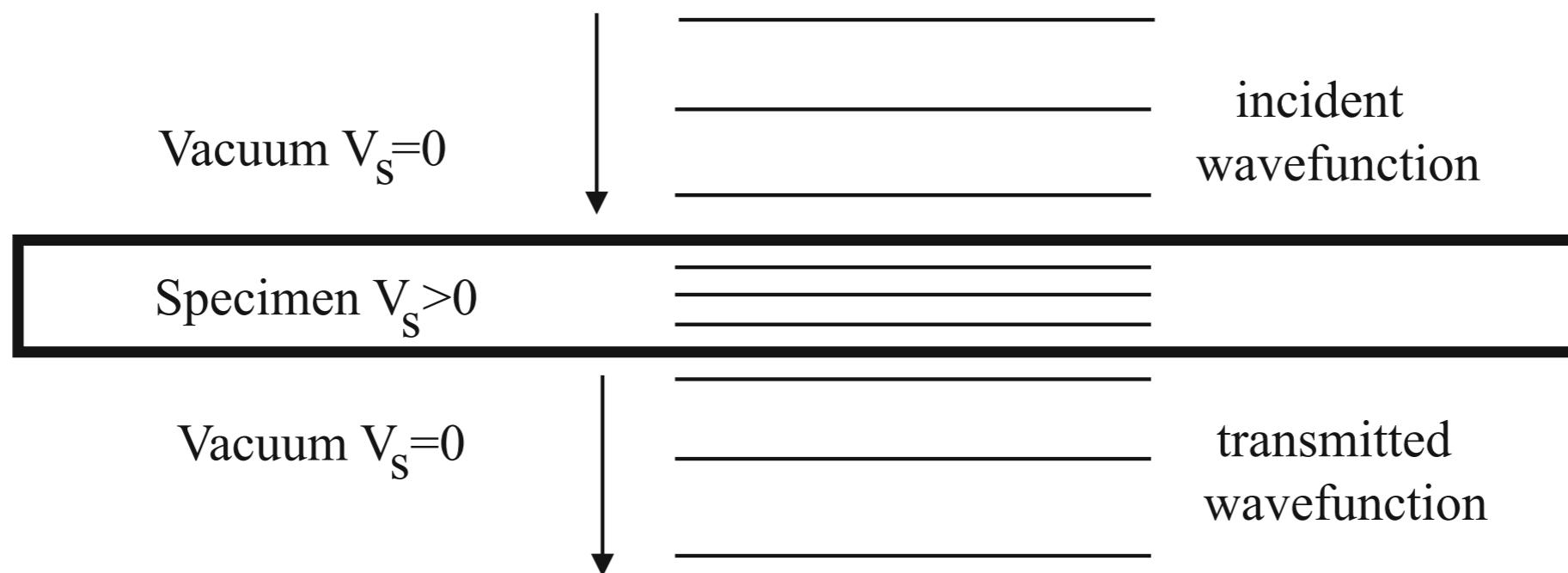
$$\psi(\mathbf{x}) = \exp(2\pi i k_z z) = \exp(2\pi i z/\lambda)$$

wavevector

$$k_z = \frac{1}{\lambda} = \frac{\sqrt{eV(2m_0c^2 + eV)}}{hc}$$

$eV$  = electron kinetic energy

For  $eV \gg V_s$  potential energy in the specimen, its effect is to cause a small change in wavelength



# Phase shift



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## Wavelength in specimen

$$\begin{aligned}\frac{1}{\lambda_s} &= \frac{[(eV + eV_s)(2m_0c^2 + eV + eV_s)]^{1/2}}{hc} \\ &= \frac{[eV(2m_0c^2 + eV) + eV_s(2m_0c^2 + 2eV + eV_s)]^{1/2}}{hc} \\ &= \frac{1}{\lambda} \left[ 1 + \frac{eV_s(2m_0c^2 + 2eV + eV_s)}{eV(2m_0c^2 + eV)} \right]^{1/2}\end{aligned}$$

## Expanding and keeping leading order in $V_s/V$

$$\frac{1}{\lambda_s} \sim \frac{1}{\lambda} \left[ 1 + \frac{eV_s(2m_0c^2 + 2eV)}{2eV(2m_0c^2 + eV)} + \dots \right] \sim k_z + \frac{V_s(m_0c^2 + eV)}{\lambda V(2m_0c^2 + eV)} + \dots$$

## Changing wavelength equivalent to a phase shift

$$\psi(\mathbf{x}) \sim \exp(2\pi i k_z z) \exp(i\sigma_e V_s z)$$

## interaction parameter

$$\sigma_e = \frac{2\pi}{\lambda V} \left( \frac{m_0c^2 + eV}{2m_0c^2 + eV} \right) = \frac{2\pi m e \lambda}{h^2}$$

---

relativistic mass  $m = \gamma m_0$

# Transmission through thin slices



For very thin specimen, phase shift = integral of potential

$$\psi_t(\mathbf{x}) = t(\mathbf{x}) \exp(2\pi i k_z z)$$

$t(\mathbf{x}) = \exp [i\sigma_e v_z(\mathbf{x})]$   $t$  = transmission function

with the projected potential

$$v_z(\mathbf{x}) = v_z(x, y)$$

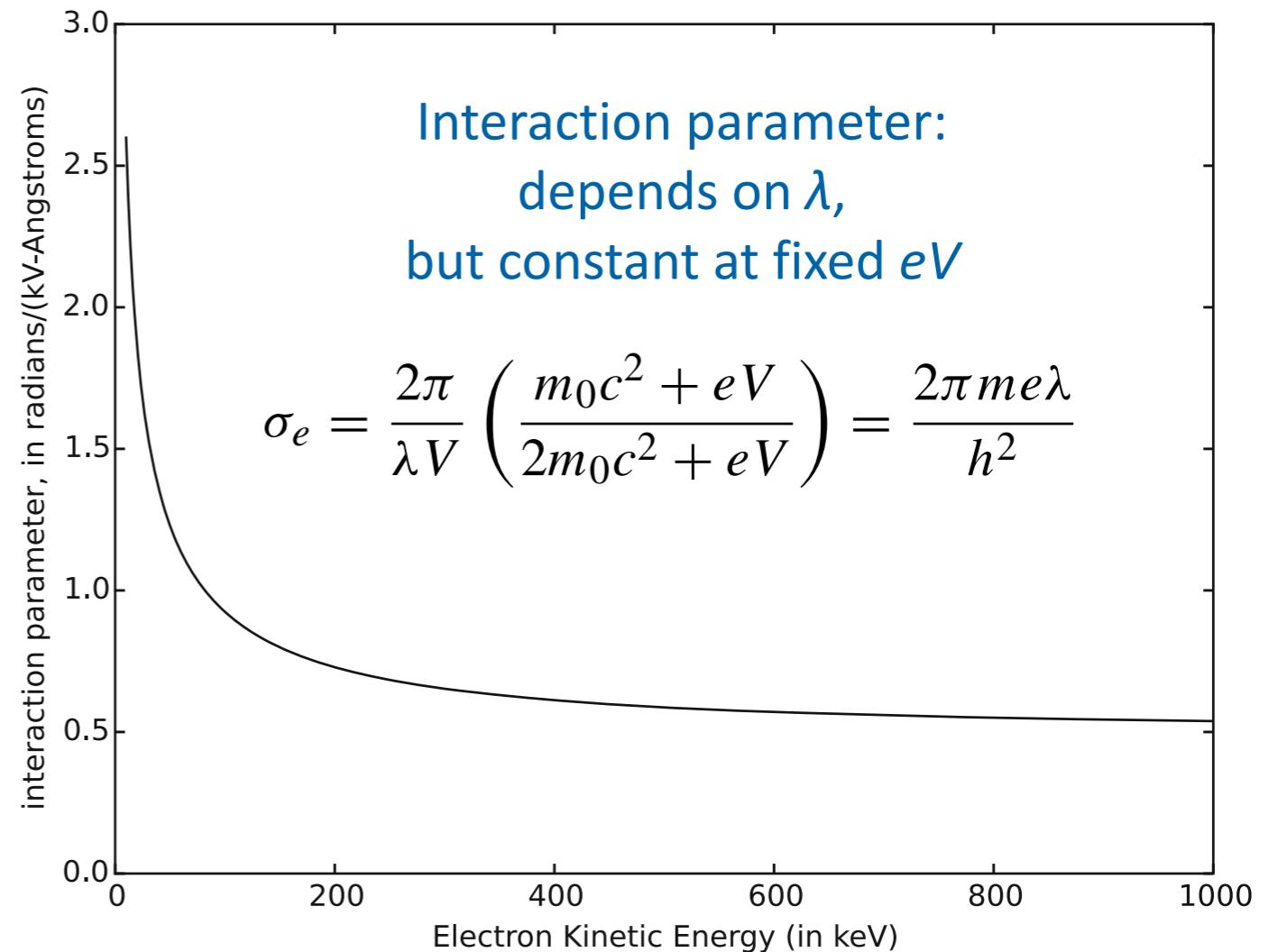
$$= \int V_s(x, y, z) dz$$

Weak phase object approx. (WPOA):

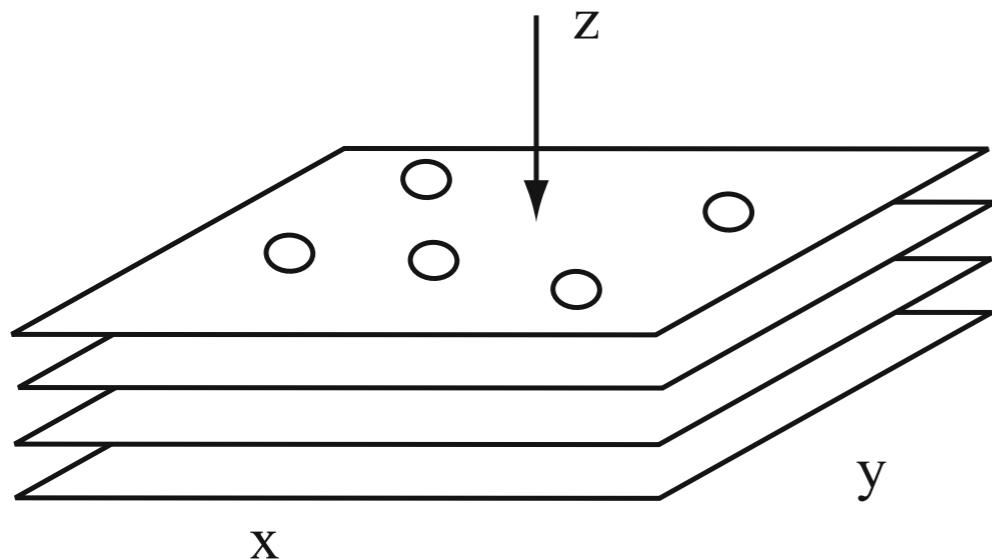
1)  $V_s \ll eV$

2) 3D potential  $\Rightarrow$  2D projection

Does NOT describe most specimens...  
... but DOES describe potential slices!

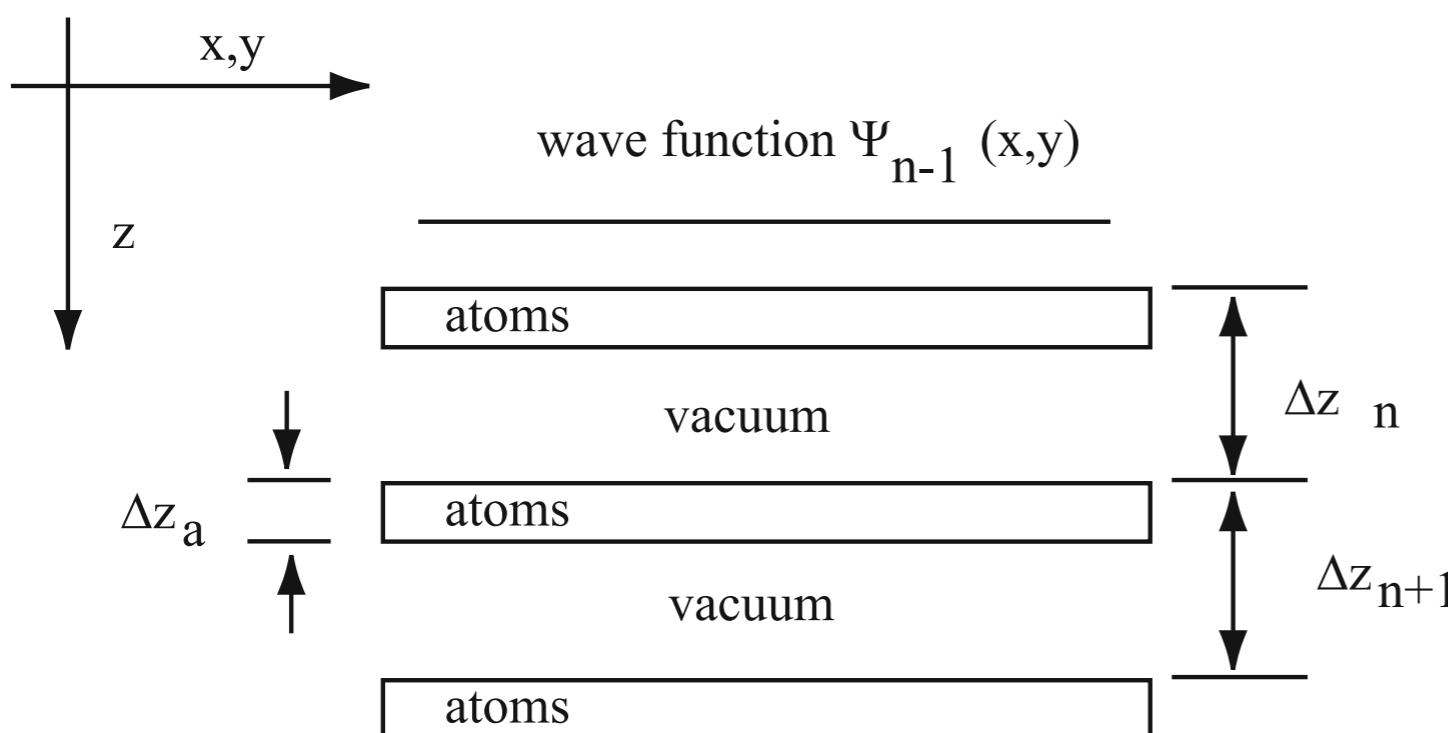


# Slicing the specimen



Each slice = thin enough for WPOA to hold

Within each slice: rectangular cell with periodic boundary conditions



Ideally: align atomic layers with the slice boundaries

If there is periodic structure along z, pre-calculating and storing transmission function is computationally efficient

# Discrete numerical simulations



- An image needs to be represented as numerical data
  - Two- dimensional array of machine-represented numbers
    - Each number is one pixel or spot in the image
    - Intensity is proportional to numerical value
  - Sufficiently large number of pixels able to represent intensities required
    - Sampling the image has rules and limitations
    - Both spatial sampling and bit depth matter
- Converting between reciprocal and real space theoretically important
  - Fast Fourier transform (FFT): one of the most efficient computer algorithms
    - Computes the Fourier transform of discretely sampled data
  - Image simulation usually organized around FFT to save time – choice of simulation method is driven by computational efficiency!

# Numerical discretization



## Real-space discretization

$$x = i \Delta x \quad i = 0, 1, 2, \dots, (N_x - 1)$$

$$y = j \Delta y \quad j = 0, 1, 2, \dots, (N_y - 1)$$

## Real-space sampling

$$\Delta x = a/N_x \text{ and } \Delta y = b/N_y$$

*Neither the pixels nor the image have to be square!*

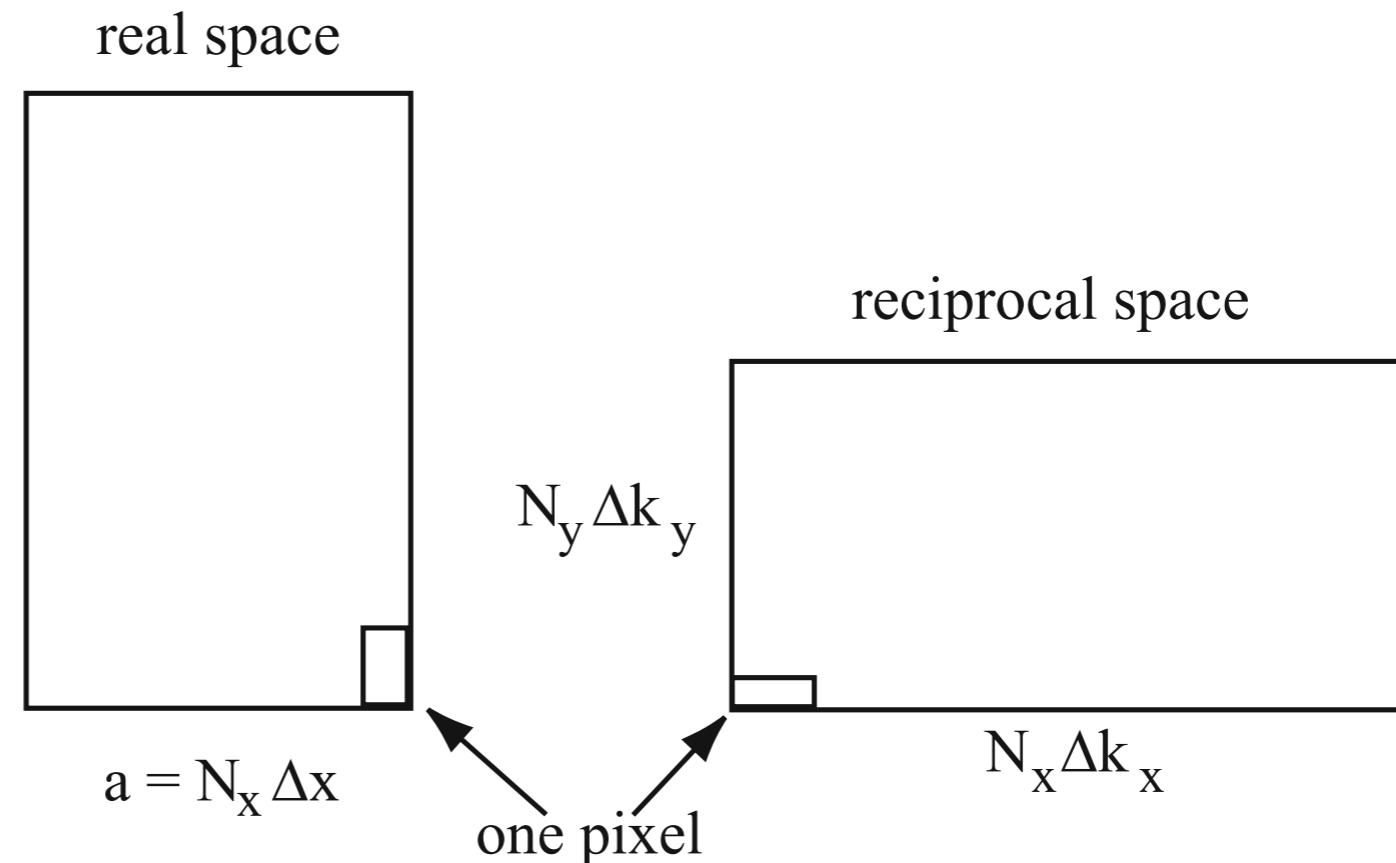
## Reciprocal-space discretization

$$k_x = i \Delta k_x \quad i = 0, 1, 2, \dots, (N_x - 1)$$

$$k_y = j \Delta k_y \quad j = 0, 1, 2, \dots, (N_y - 1)$$

## Reciprocal-space sampling

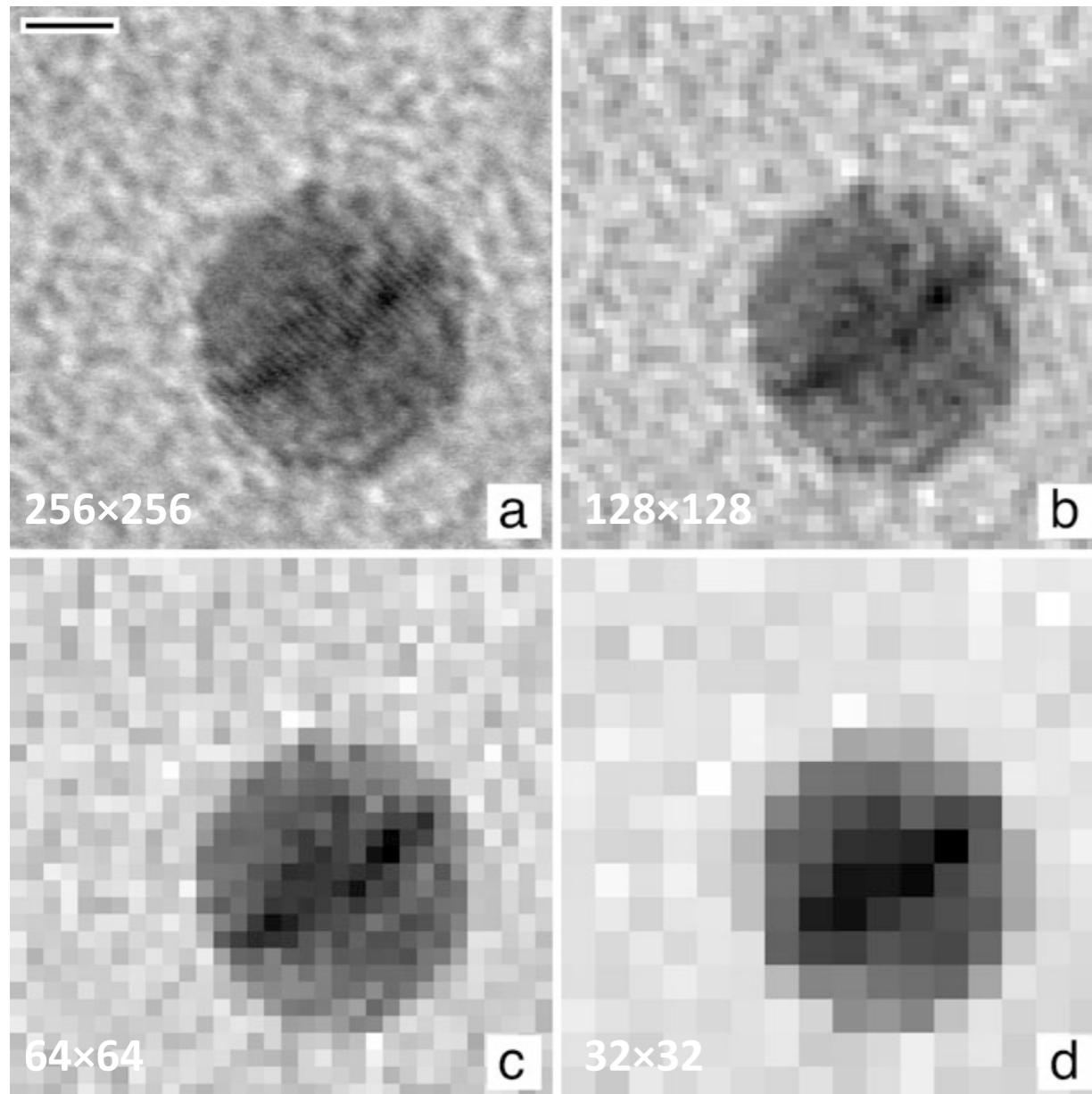
$$\Delta k_x = 1/a \text{ and } \Delta k_y = 1/b$$



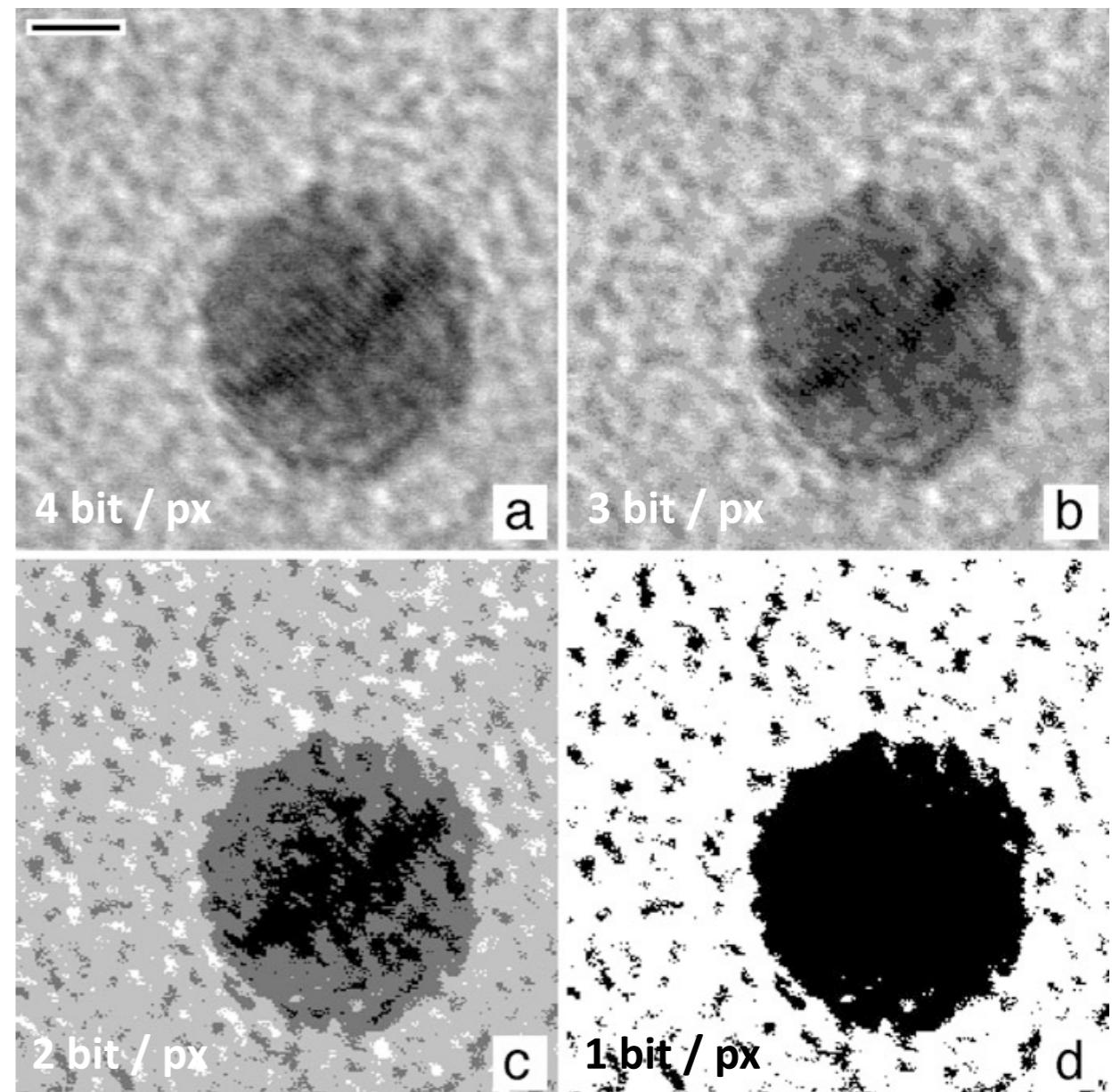
# Pixel sampling and bit depth



Experimental: as many pixels as in camera/scan



Typically store 32-bit, display: 8-bit



# Sampling



## Maximum spatial frequency

$$|k_x| < \frac{1}{2\Delta x}$$

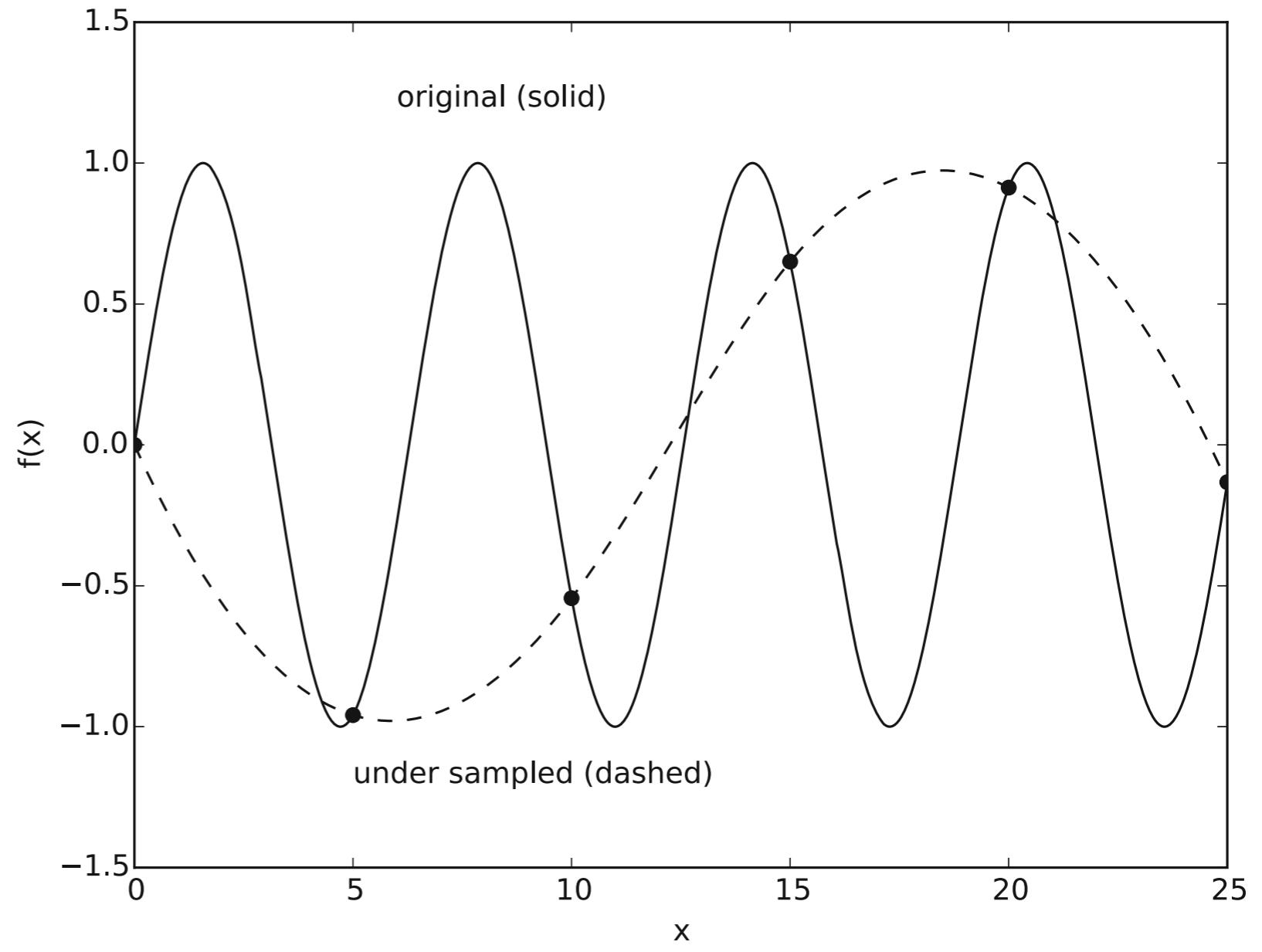
$$|k_y| < \frac{1}{2\Delta y}$$

This is the **Nyquist limit**.

Sampling less densely will lead to loss of information.

Sampling more densely may be redundant (abTEM can in many cases interpolate).

## Effect of under-sampling

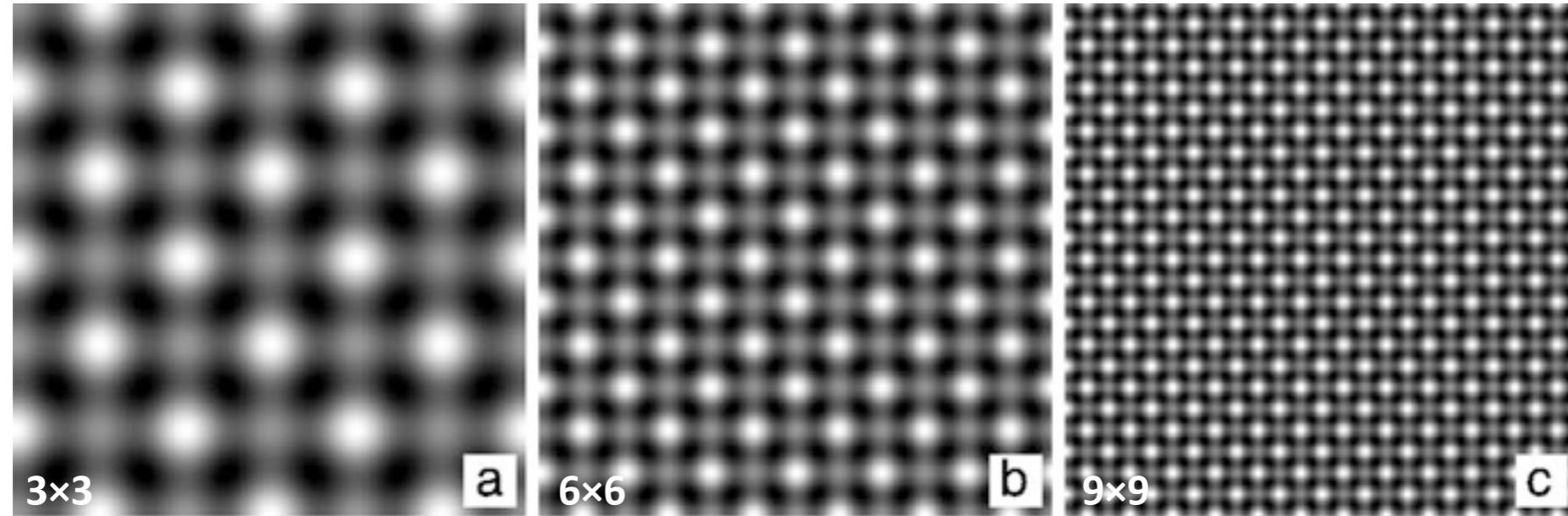


high frequencies get “aliased” as low frequencies

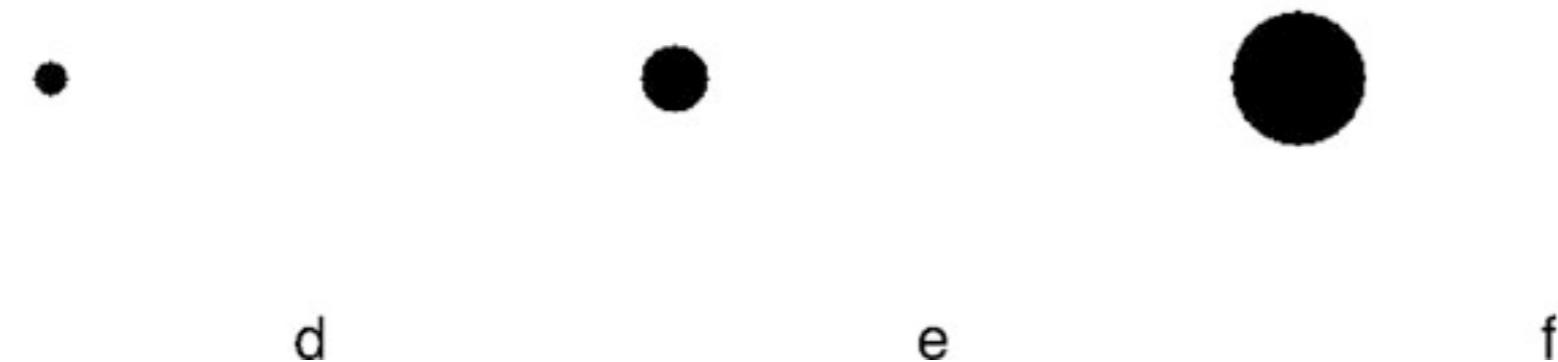
# Real vs. reciprocal space sampling



Increasing real-space supercell size at a fixed 256×256 pixels



Sampling in real space and reciprocal space are **inversely coupled**.



Objective aperture sampling in reciprocal space increases (more pixels)



## Calculate and parametrize

- Calculate atomic all-electron density using first-principles modeling (e.g. Hartree-Dirac-Fock, all-electron DFT, etc)
- Choose functional form for parametrization

$$f_e(q) = \sum_{i=1}^{N_L} \frac{a_i}{q^2 + b_i} + \sum_{i=1}^{N_G} c_i \exp(-d_i q^2) \quad \text{Kirkland parameterization}$$

- Calculate potential, Fourier-transform  $\Rightarrow$  atomic form factor
- Optimize parameters for each element to fit form factor

$$\chi^2 = \frac{1}{2N_q - 2N_L - 2N_G} \sum_{j=1}^{N_q} \left\{ \left[ \frac{f_{xj} - f_x(q_j)}{\sigma_{xj}} \right]^2 + \left[ \frac{f_{ej} - f_e(q_j)}{\sigma_{ej}} \right]^2 \right\} \quad \text{minimize fit error}$$

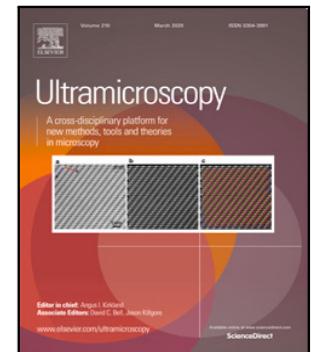
- End result: numerically fast form factors (potentials) for each element

# *ab initio* description of bonding for transmission electron microscopy

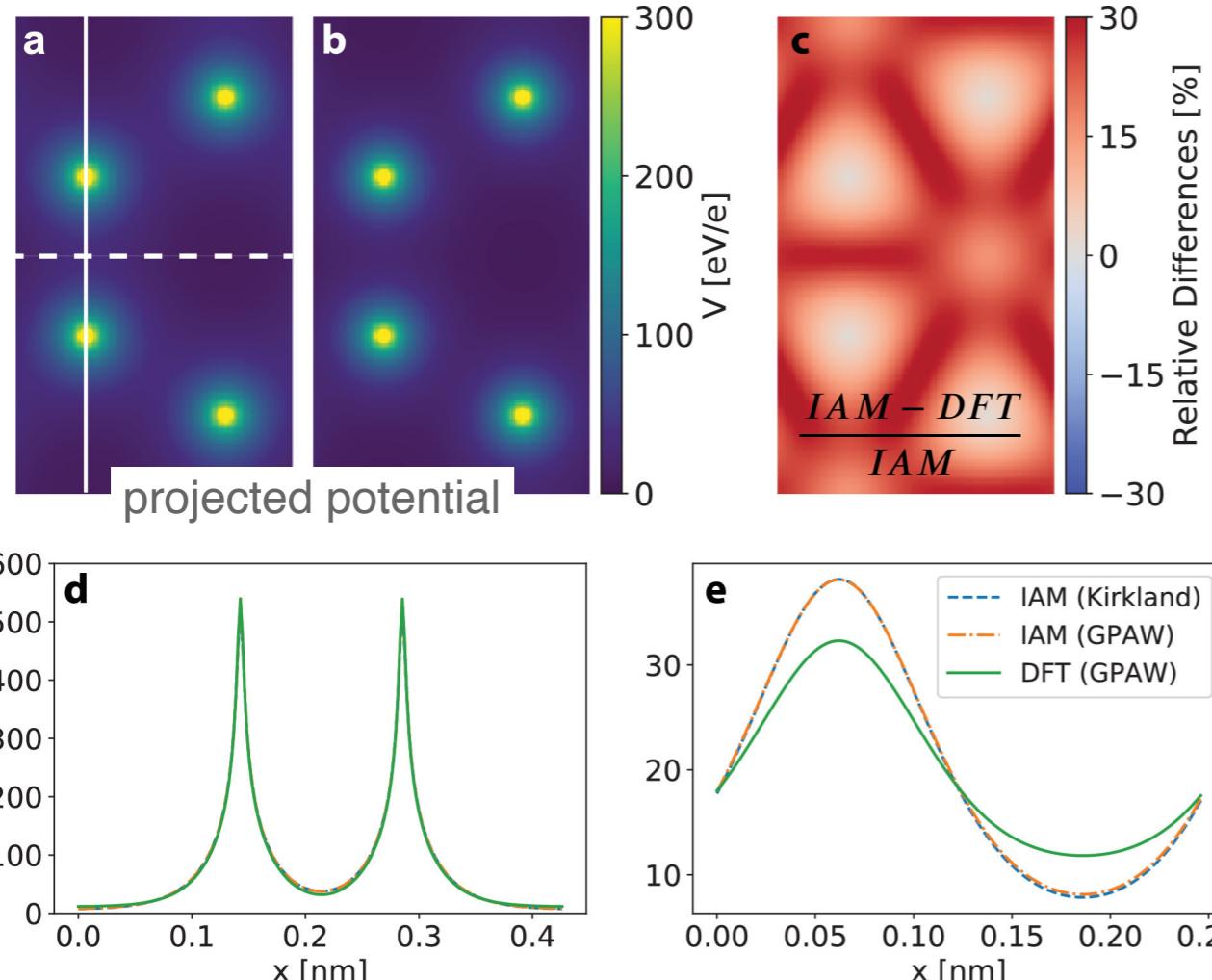
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TS *et al.*, Ultramicroscopy, 197 (2019) 16–22



**Table 2**

*ab initio* simulations of the electrostatic potential of materials for explicit TEM electron scattering simulations. See the caption of Table 1 for a description of the different treatments of core electrons.

DFT code	Core electrons	Material	Refs.
WIEN2K	FLAPW	MgO	[64]
WIEN2K	FLAPW	graphene, hBN	[6,65]
SIESTA	pseudo	graphene	[66]
QUANTUM ESPRESSO	pseudo	AlN	[67]
EXCITING	FLAPW	graphene	[68]
ABINIT/ELK	pseudo	WSe <sub>2</sub>	[69,70]
WIEN2K	FLAPW	GaN	[22]
VASP	pseudo	SrTiO <sub>3</sub>	[71]
GPAW	PAW	graphene, hBN	[52,72]
CASTEP/WIEN2K	pseudo, FLAPW	hBN	[73]
FPLO-18	FLAPW	graphene, hBN	[74]
GPAW	PAW	GaP	[75]

Many different DFT codes,  
many multislice codes...

...but none with direct integration  
with *ab initio* scattering potentials

Bonding effects do matter for HRTEM,  
holography quantitative ED, 4D-STEM...



# abTEM code: TEM from first principles



## Our design goals

1. Integration with atomistic codes



2. Python, but *fast*



CuPy

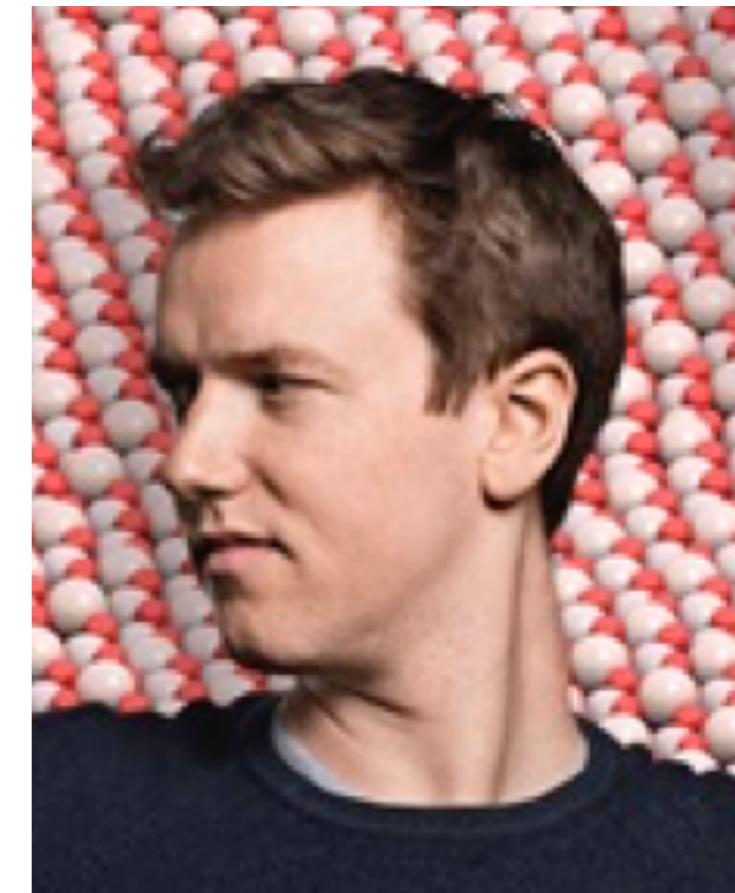


3. Promote notebook/scripted workflow



4. Access to low-level API: Easy to extend

5. Open source (huge ecosystem!)

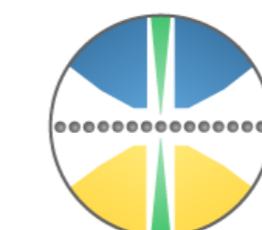


Dr. Jacob Madsen

high-performance parallel GPUs & file access



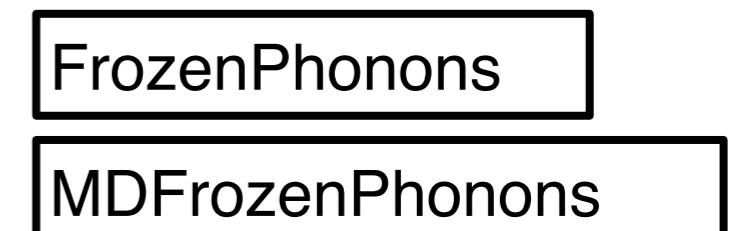
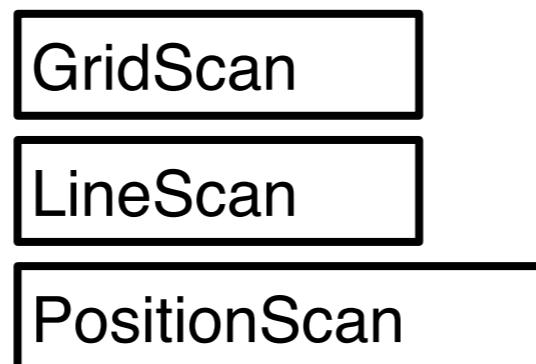
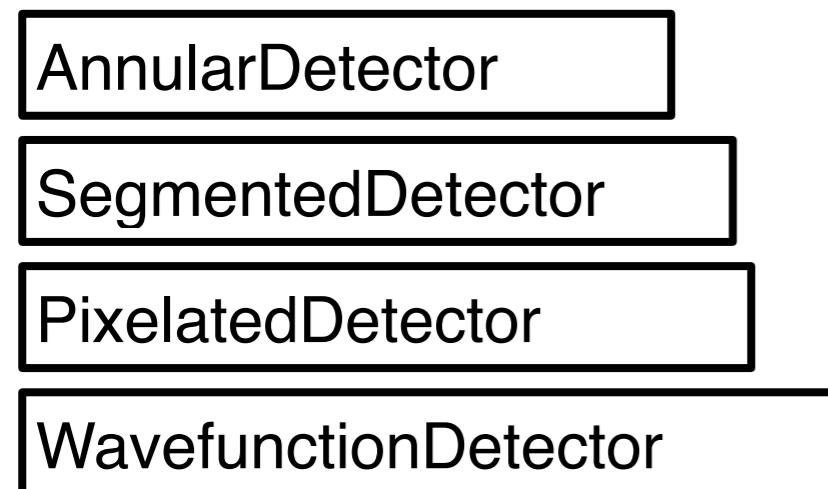
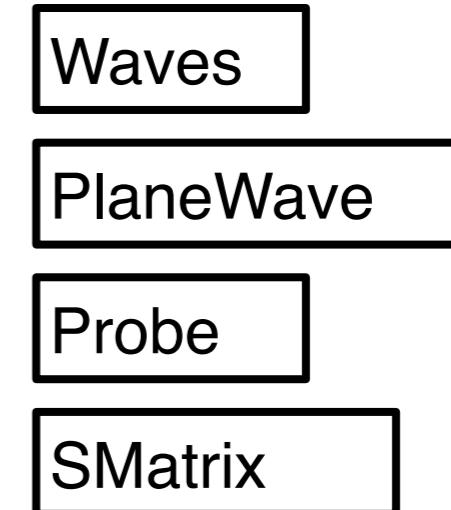
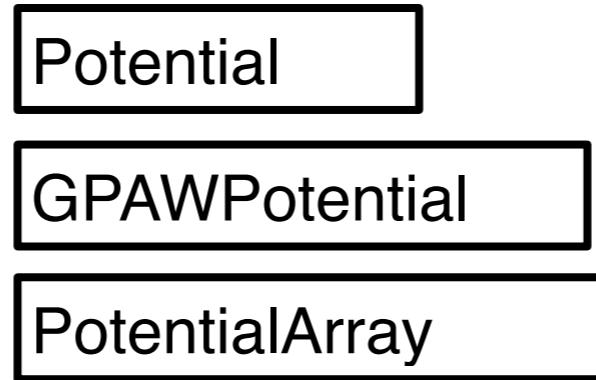
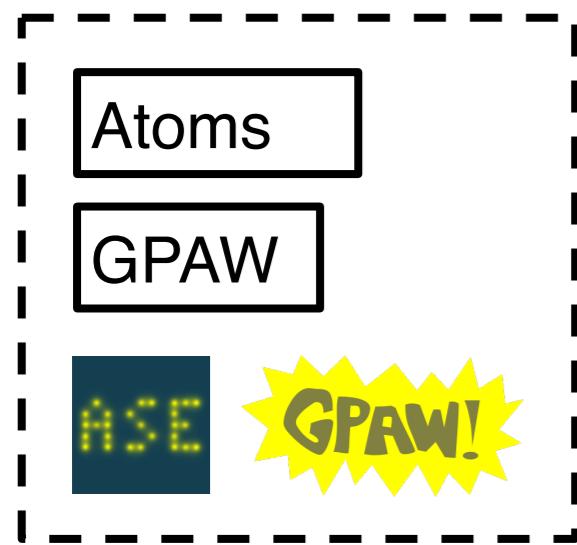
CUDA<sup>®</sup>



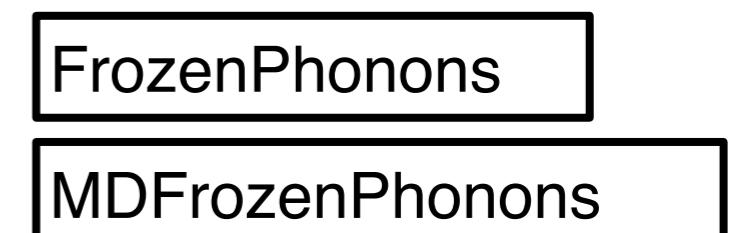
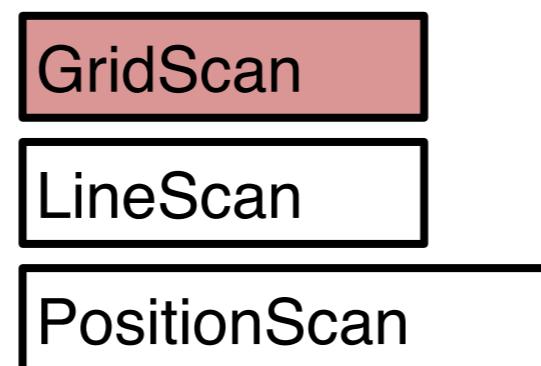
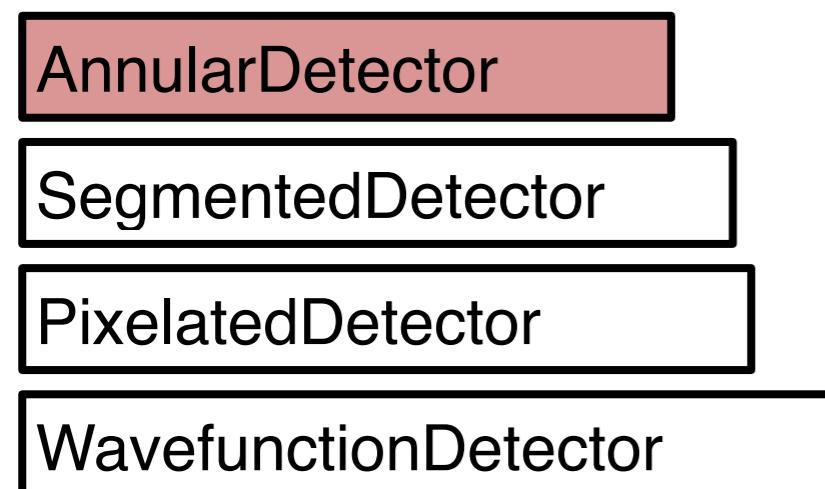
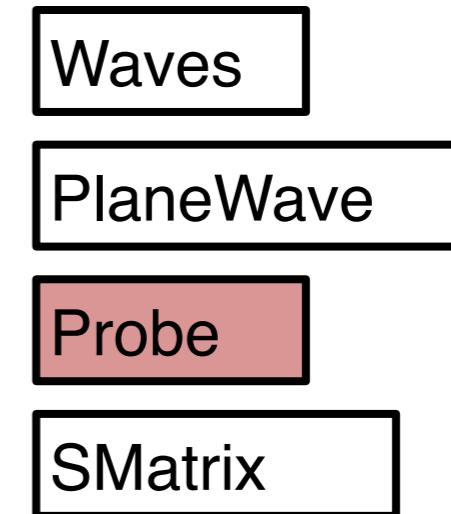
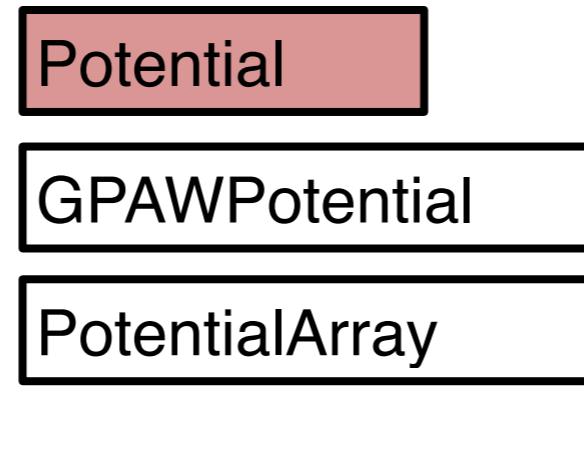
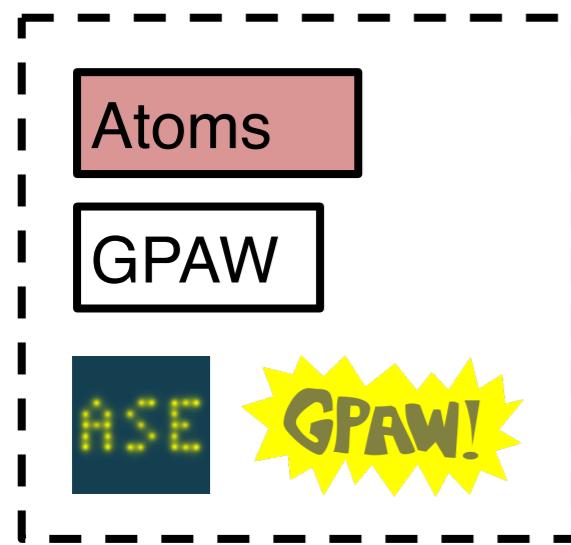
abTEM

[github.com/abTEM/abTEM](https://github.com/abTEM/abTEM)

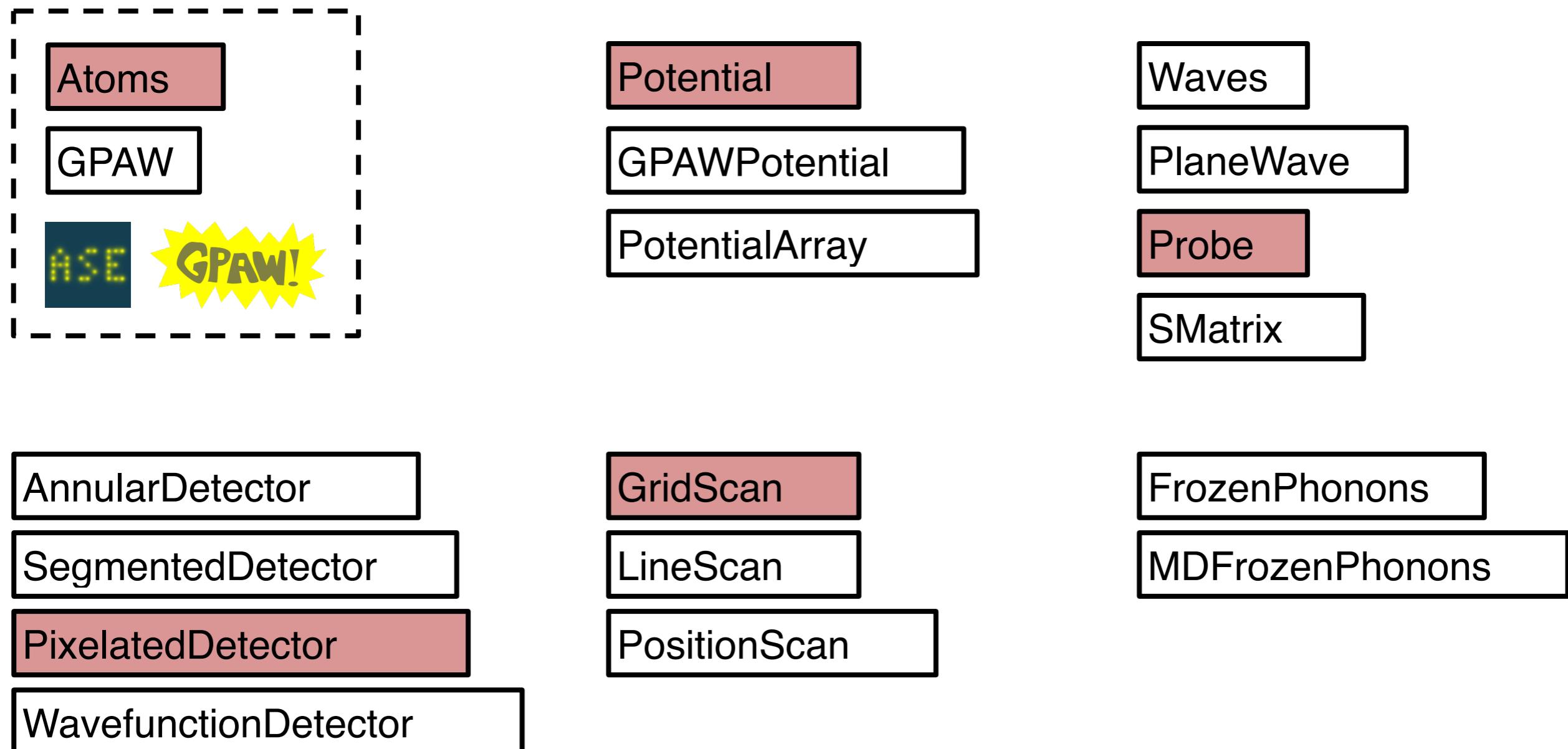
# *abTEM*'s API: interchangeable objects



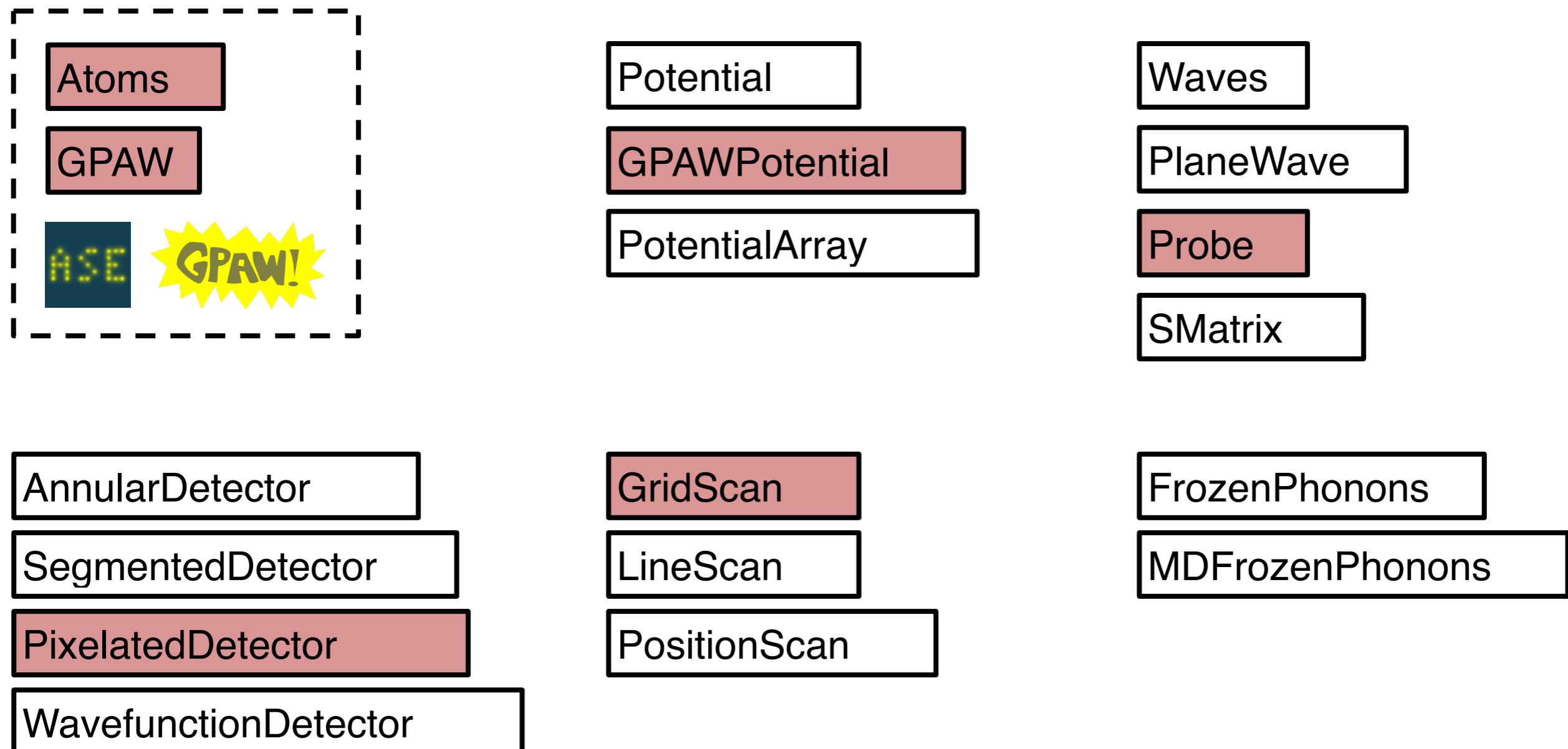
# *abTEM's API: STEM/ADF image with IAM*



# *abTEM*'s API: 4D-STEM with IAM



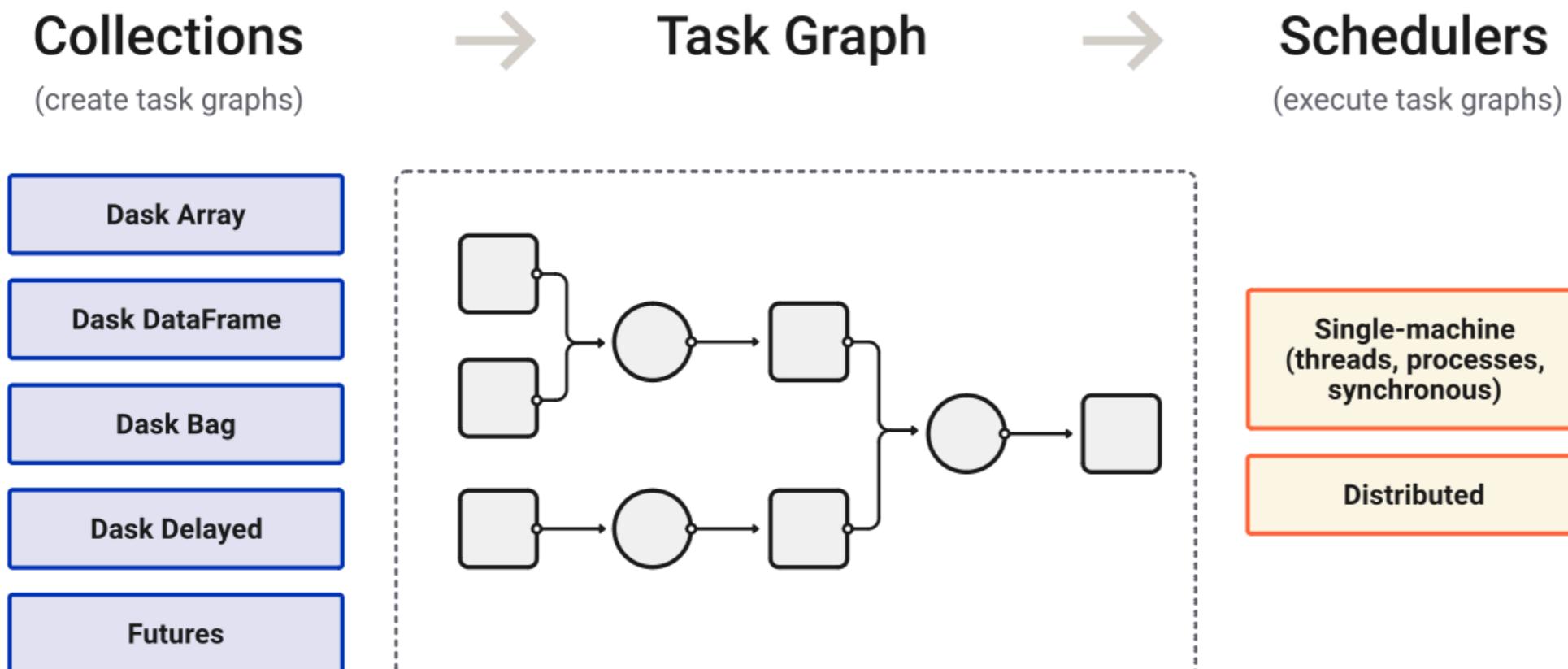
# *abTEM*'s API: 4D-STEM with DFT



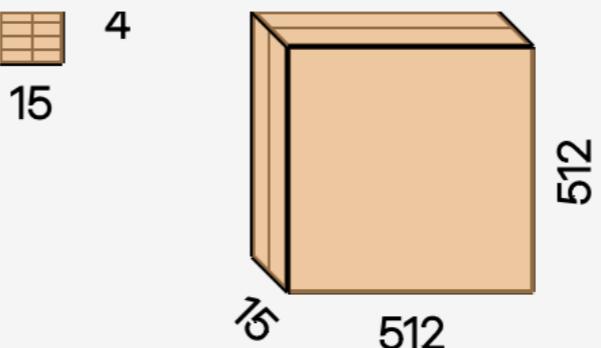


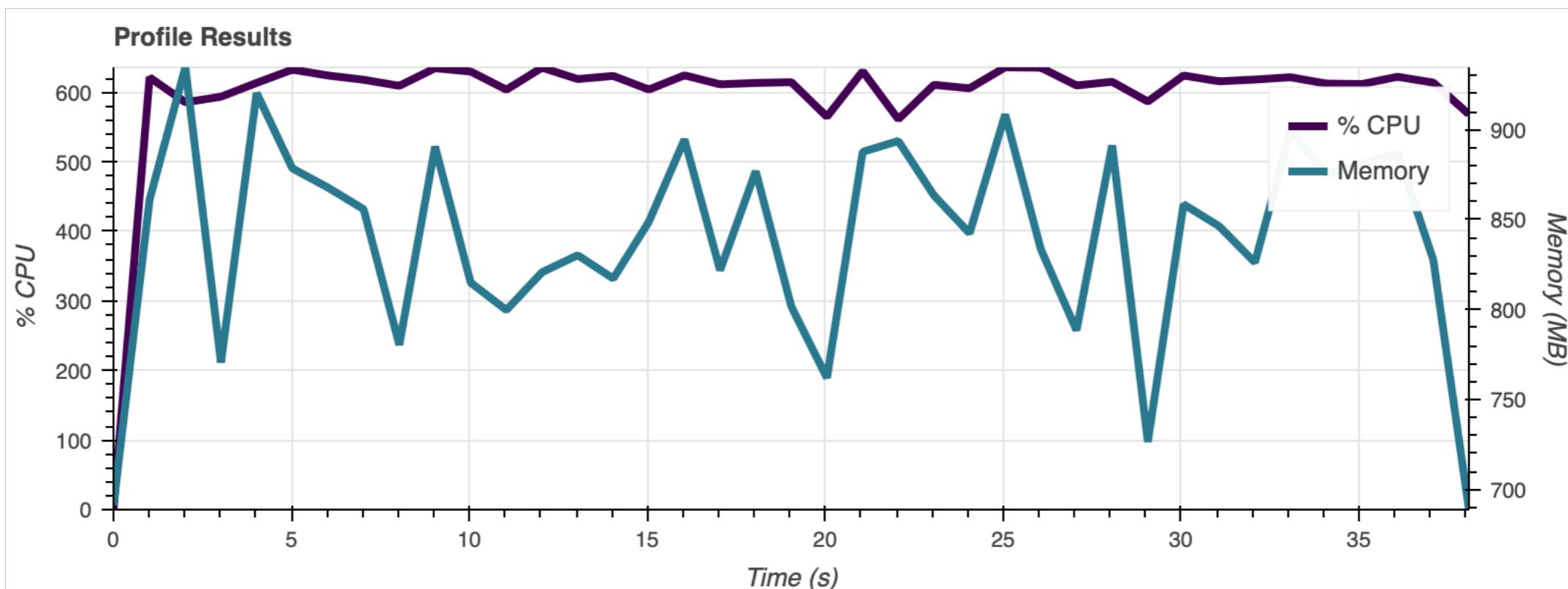
# Task graphs

Simulating TEM experiments requires executing multiple *tasks* where each one may depend on the output of previous tasks. In Dask this is represented as a **task graph**, where each task is a *node*, with edges between nodes if it is dependent on another task. The simulation result is obtained by executing each task (node) in the graph with a Dask *scheduler* on a single machine or a cluster.

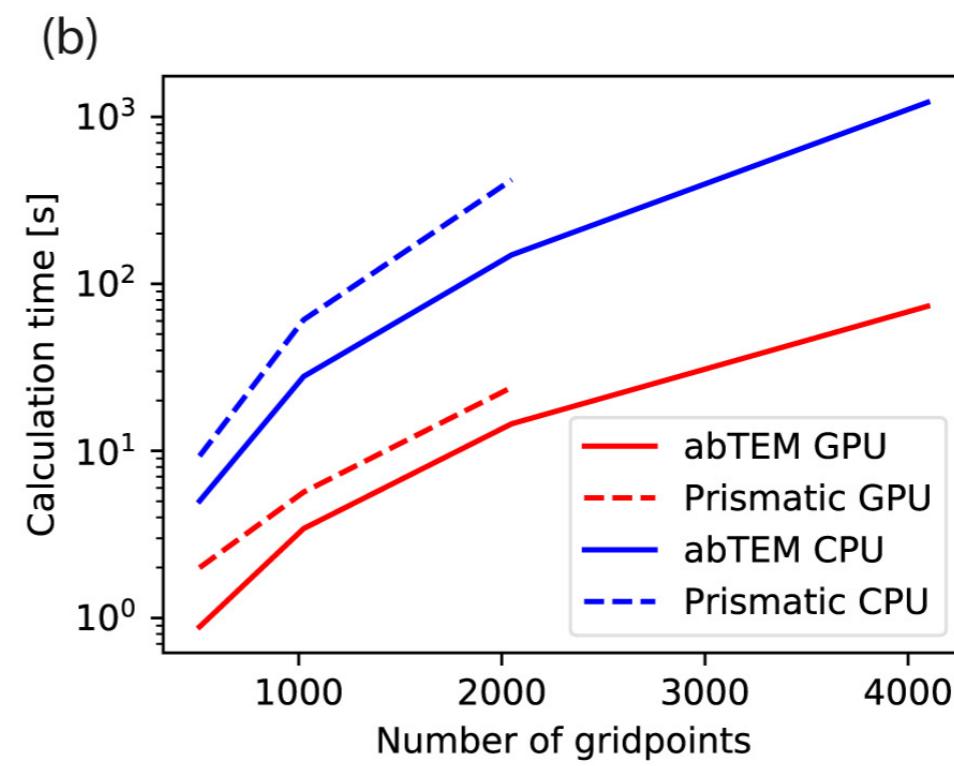
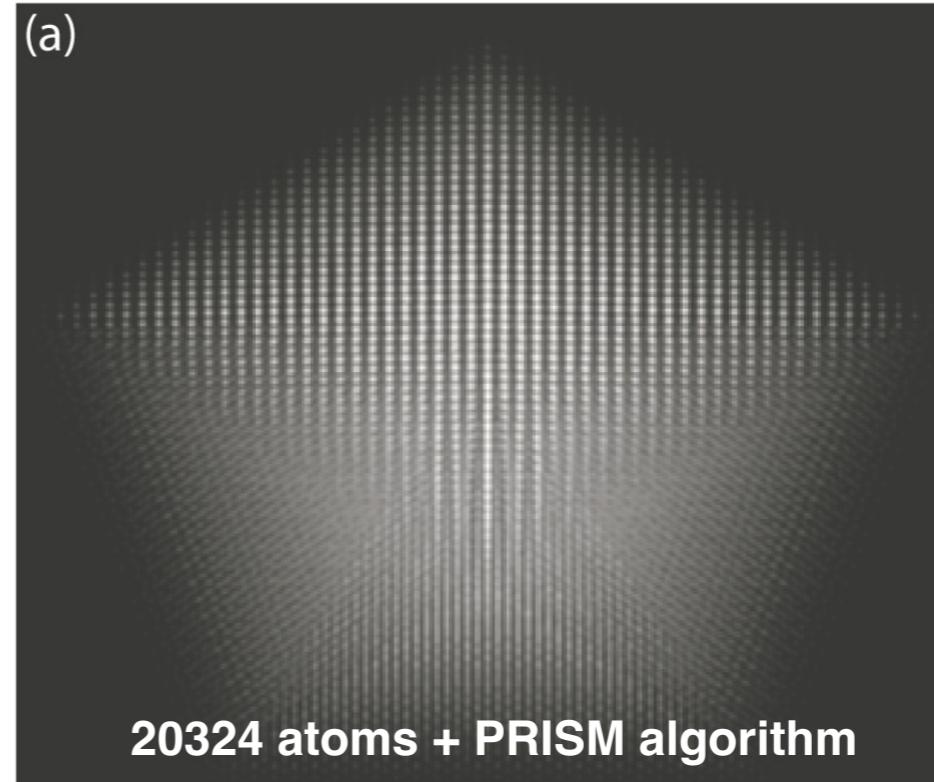
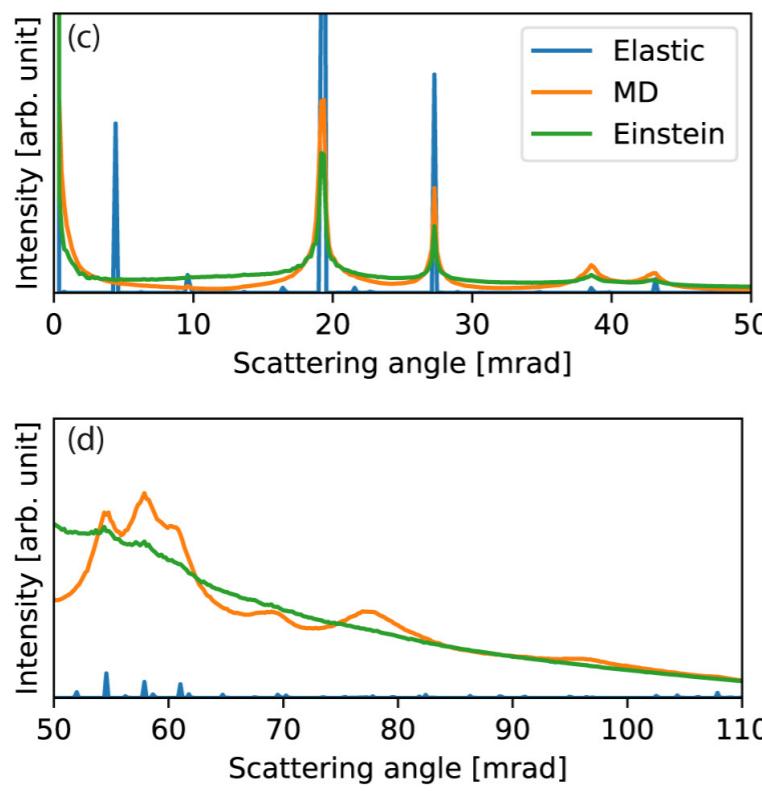
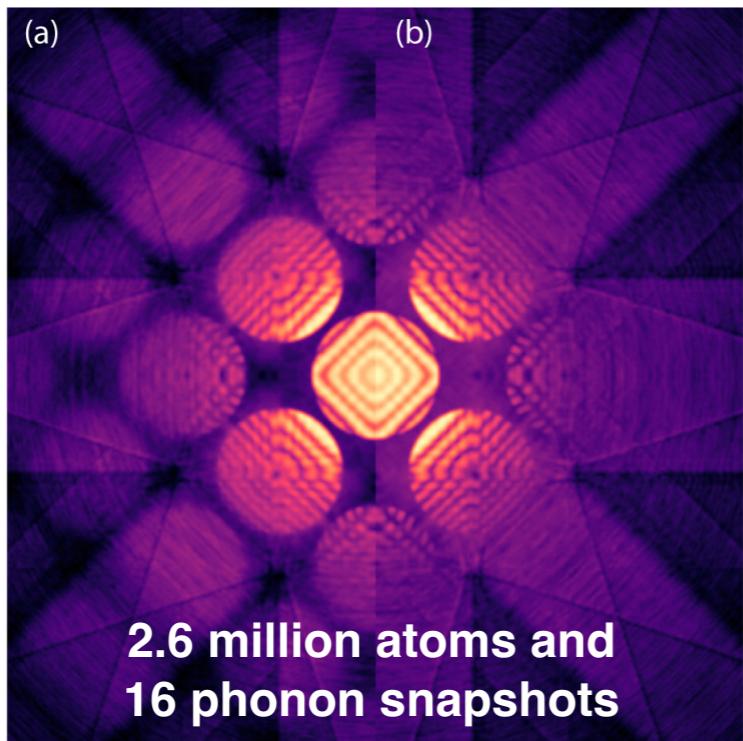


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FrozenPhononsAxis	Frozen phonons	-
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ScanAxis	y [Å]	0.00 0.27 ... 3.81
RealSpaceAxis	x [Å]	0.00 0.04 ... 20.36
RealSpaceAxis	y [Å]	0.00 0.04 ... 20.36

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<b>Count</b>	17 Graph Layers	24 Chunks	
<b>Type</b>	complex64	numpy.ndarray	



# abTEM: Python, but *fast*





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⌘ + K

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## Welcome!

### abTEM: transmission electron microscopy from first principles

abTEM is a flexible open-source package for simulating transmission electron microscopy experiments. We strive for easy integration with other simulation codes and analysis tools accessible from Python. Utilization of other open-source projects makes abTEM fast and scalable from a laptop to a high-performance computing environment.

Here are a few links to help you get started; please also note the navigation menu on the left side of the page.

#### Getting started

New to abTEM? Visit our guides for getting started. They will introduce you to abTEM's main concepts, help you install the code, and provide links to basic examples.

#### User guide

The user guide provides in-depth information about the key concepts of abTEM with background information about simulations of transmission electron microscopy experiments.

#### Example gallery

Our example gallery provides fully functional code templates to assist with your common simulation tasks, for demonstrating a unique topic, or for reproducing result in published research articles.

#### API reference

Our reference contains a detailed description of the abTEM API based on code documentation. It describes the methods and their parameters, and assumes that you have an understanding of the key concepts.

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